Notice of References Cited Application/Control No. 10/723,002 Examiner Magda Cruz Applicant(s)/Patent Under Reexamination TENG ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0089651	07-2002	Ejiri et al.	353/69
*	В	US-6,056,408	05-2000	Kobayashi, Kiwamu	353/122
*	С	US-2002/0008697	01-2002	Deering, Michael F.	345/418
*	۵	US-6,339,434	01-2002	West et al.	345/667
	E	US-	•		
	F	US-			
	G	US-			
	Н	US-			•
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
	R					
	s					·
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.